

Search Notes

Application/Control No.

10/623,912

Examiner

Edward Wojciechowicz

Applicant(s)/Patent under
Reexamination

CHIH ET AL

Art Unit

2815

SEARCHED

| Class | Subclass | Date | Examiner |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
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| <i>EAST 257/314 update</i> | <i>8-15-05</i> | <i>EDL</i> |
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